

2 MEG (262144 words × 8 bits) Mask ROM Internal Clocked Silicon Gate

LC372100PP, PM, PT-10/20LV

Preliminary

Overview

The LC372100PP, LC372100PM and LC372100PT are 262,144-word \times 8-bit organization (2,097,152-bit) mask programmable read only memories.

The LC372100PP-10, LC372100PM-10 and LC372100PT-10 feature an access time of 100 ns, an OE access time of 40 ns, and a standby current of 30 μ A, and are optimal for use in 5-V systems that require high-speed access.

The LC372100PP-20LV, LC372100PM-20LV and LC372100PT-20LV feature an access time of 200 ns, an OE access time of 80 ns, and a standby current of 4 μ A, and thus are optimal for use in 3-V systems that use batteries. Additionally, they provide high-speed access in 3.3-V systems (3.0 to 3.6 V) with a 150-ns access time and a 60-ns OE access time.

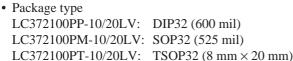
These ROMs adopt the JEDEC standard pin assignment which allows them to replace EPROM easily. To prevent bus line collisions in multi-bus microcontroller systems, pin 24 can be mask programmed to be either active high or active low.

Features

- 262144 words × 8 bits organization
- Power supply LC372100PP, PM, PT-10: 5.0 V ± 10% LC372100PP, PM, PT-20LV: 2.7 to 3.6 V
- Fast access time (t_{AA}, t_{CA}) LC372100PP, PM, PT-10: 100 ns (max.) LC372100PP, PM, PT-20LV: 200 ns (max.) 150 ns

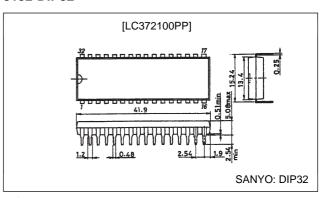
 $(V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$

- Operating current LC372100PP, PM, PT-10: 70 mA (max.) LC372100PP, PM, PT-20LV: 20 mA (max.)
- Standby current LC372100PP, PM, PT-10: 30 μA (max.) LC372100PP, PM, PT-20LV: 5 μA (max.)
- Full static operation (internal clocked type)
- Fully TTL compatible (5 V supply)
- 3 state outputs
- JEDEC standard pin configuration



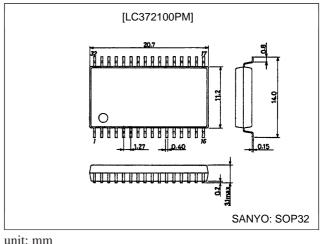
Package Dimensions

unit: mm **3192-DIP32**

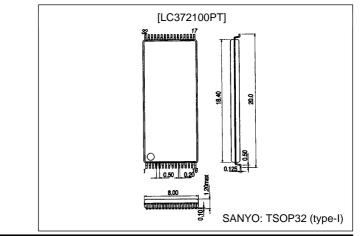


unit: mm

3205-SOP32



3224-TSOP32

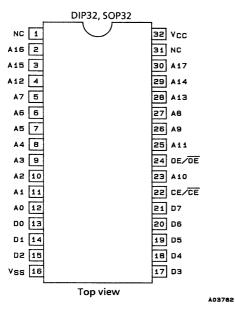


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CMOS IC

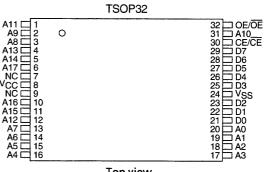
53098HA (OT)/51195TH (OT)/41095TH (OT) No. 5088-1/5

Pin Assignments



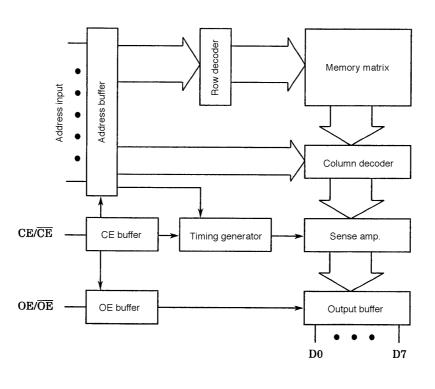
Pin Functions

| A0 to A17 | Address input |
|-----------------|---------------------|
| D0 to D7 | Data output |
| CE/CE | Chip enable input |
| OE/OE | Output enable input |
| V _{CC} | Power supply |
| V _{SS} | Ground |



Top view

Block Diagram



Truth Table

| CE/CE | OE/OE | Output | Current drain |
|-------|-------|----------------|----------------|
| L/H | Х | High-impedance | Standby mode |
| H/L | L/H | High-impedance | Operating mode |
| H/L | H/L | DOUT | Operating mode |

X: H or L level should be offered.

A08705

Specifications Absolute Maximum Ratings *1

| Parameter | Symbol | Conditions | Ratings | Unit |
|-----------------------------|---------------------|---|--------------------------------------|------|
| Maximum supply voltage | V _{CC} max | | -0.3 to +7.0 | V |
| Supply input voltage | V _{IN} | | -0.3^{*2} to V _{CC} + 0.3 | V |
| Supply output voltage | V _{OUT} | | -0.3 to V _{CC} + 0.3 | V |
| Allowable power dissipation | Pd max | Ta = 25°C; Reference values for the SANYO DIP package | 1.0 | W |
| Operating temperature | Topr | | 0 to +70 | °C |
| Storage temperature | Tstg | | -55 to +125 | °C |

Note: 1. Permanent device damage may occur if Absolute Maximum Ratings are exceeded. Functional operation should be restricted to Recommended Operating Conditions.

2. V_{IN} (min) = -3.0 V (pulse width \leq 30 ns)

Input/Output Capacitance* at Ta = 25°C, f = 1.0 MHz

| Parameter Symb | | Conditions | | Ratings | | | |
|--------------------|------------------|--|-----|---------|-----|------|--|
| Farameter | Symbol | Conditions | min | typ | max | Unit | |
| Input capacitance | CIN | V_{IN} = 0 V; Reference values for the SANYO DIP package | | | 8 | pF | |
| Output capacitance | C _{OUT} | $V_{OUT} = 0 V$; Reference values for the SANYO DIP package | | | 10 | pF | |

Note: * This parameter is periodically sampled and not 100% tested.

3 V Operation

DC Recommended Operating Ranges at Ta = 0 to $+70^{\circ}C$

| Parameter | Symbol Conditions – | | Unit | | | |
|--------------------------|---------------------|------------|---------------------|-----|-----------------------|---|
| | | Conditions | min | typ | max | |
| Supply voltage | V_{CC} max | | 2.7 | 3.0 | 3.6 | V |
| Input high level voltage | V _{IH} | | 0.8 V _{CC} | | V _{CC} + 0.3 | V |
| Input low level voltage | V _{IL} | | -0.3 | | +0.4 | V |

DC Electrical Characteristics at Ta = 0 to +70°C, V_{CC} = 2.7 to 3.6 V

| Parameter | Sumbol | Symbol Conditions | | Ratings | | | | |
|---------------------------|-------------------|---|----------------|---------|----------|------|--|--|
| Farameter | Symbol | Conditions | min | typ | max | Unit | | |
| Operating supply current | I _{CCA1} | \overline{CE} = 0.2 V (CE = V _{CC} - 0.2 V), V _I = V _{CC} - 0.2 V/0.2 V | | | 15 | mA | | |
| | I _{CCA2} | $\overline{CE} = V_{IL} (CE = V_{IH}), I_O = 0 \text{ mA}, V_I = V_{IH}/V_{IL}, f = 5 \text{ MHz}$ | | | 20 | mA | | |
| Standby supply current | I _{CCS1} | $\overline{CE} = V_{CC} - 0.2 V (CE = 0.2 V)$ | | | 5 (0.5*) | μA | | |
| Standby supply current | I _{CCS2} | $\overline{CE} = V_{IH} (CE = V_{IL})$ | | | 50 (10*) | μA | | |
| Input leakage current | ILI | $V_{IN} = 0$ to V_{CC} | | | ±1.0 | μA | | |
| Output leakage current | I _{LO} | \overline{CE} or \overline{OE} = V _{IH} (CE or OE = V _{IL}), V _{OUT} = 0 to V _{CC} | | | ±1.0 | μA | | |
| Output high level voltage | V _{OH} | I _{OH} = -0.5 mA | $V_{CC} - 0.2$ | | | V | | |
| Output low level voltage | V _{OL} | I _{OL} = 0.5 mA | | | 0.2 | V | | |

Note: * Guaranteed at Ta = 25°C

AC Characteristics at Ta = 0 to $+70^{\circ}$ C, V_{CC} = 2.7 to 3.6 V

| Parameter | Symbol | Conditions | | - Unit | | |
|-----------------------|--------------------|------------|-------------|--------|-------------|----|
| | | Conditions | min | typ | max | |
| Cycle time | t _{CYC} | | 200 (150*2) | | | ns |
| Address access time | t _{AA} | | | | 200 (150*2) | ns |
| CE access time | t _{CA} | | | | 200 (150*2) | ns |
| OE access time | t _{OA} | | | | 80 (60*2) | ns |
| Output hold time | t _{OH} | | 25 | | | ns |
| Output disable time*1 | t _{OD} *1 | | | | 50 | ns |

Note: 1. t_{OD} is measured from the earlier edge of the \overline{CE} (CE) or \overline{OE} (OE)'s going high impedance.

This parameter is periodically sampled and not 100% tested.

2. Guaranteed at V_{CC} = 3.0 to 3.6 V

5 V Operation

DC Recommended Operating Ranges at Ta = 0 to $+70^{\circ}C$

| Parameter | Symbol Conditions | | Unit | | | |
|--------------------------|---------------------|------------|------|-----|-----------------------|------|
| Faranielei | Symbol | Conditions | min | typ | max | Unit |
| Supply voltage | V _{CC} max | | 4.5 | 5.0 | 5.5 | V |
| Input high level voltage | V _{IH} | | 2.2 | | V _{CC} + 0.3 | V |
| Input low level voltage | V _{IL} | | -0.3 | | +0.6 | V |

DC Electrical Characteristics at Ta = 0 to +70 $^{\circ}C,$ V_{CC} = 5.0 V $\pm 10\%$

| Parameter | Symbol | Symbol Conditions | | Ratings | | | | |
|---------------------------|-------------------|---|-----|---------|------------|---------|--|--|
| Farameter Symbol | | Conditions | min | typ | max | Unit | | |
| Operating supply current | I _{CCA1} | \overline{CE} = 0.2 V (CE = V _{CC} - 0.2 V), V _I = V _{CC} - 0.2 V/0.2 V | | | 30 | mA | | |
| | I _{CCA2} | $\overline{\text{CE}} = \text{V}_{\text{IL}} \text{ (CE} = \text{V}_{\text{IH}}\text{)}, \text{ I}_{\text{O}} = 0 \text{ mA}, \text{ V}_{\text{I}} = \text{V}_{\text{IH}}\text{/}\text{V}_{\text{IL}}\text{, } \text{f} = 10 \text{ MHz}$ | | | 70 | mA | | |
| Standby supply current | I _{CCS1} | $\overline{CE} = V_{CC} - 0.2 \text{ V} (CE = 0.2 \text{ V})$ | | | 30 (1.0*) | μA | | |
| Standby supply current | I _{CCS2} | $\overline{CE} = V_{IH} (CE = V_{IL})$ | | | 1.0 (300*) | mA (µA) | | |
| Input leakage current | ILI | $V_{IN} = 0$ to V_{CC} | | | ±1.0 | μA | | |
| Output leakage current | ILO | \overline{CE} or $\overline{OE} = V_{IH}$ (CE or OE = V _{IL}), V _{OUT} = 0 to V _{CC} | | | ±1.0 | μA | | |
| Output high level voltage | V _{OH} | $I_{OH} = -1.0 \text{ mA}$ | 2.4 | | | V | | |
| Output low level voltage | V _{OL} | I _{OL} = 2.0 mA | | | 0.4 | V | | |

Note: * Guaranteed at Ta = 25°C

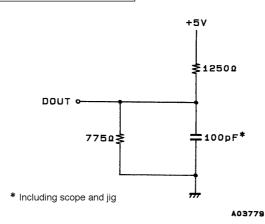
AC Characteristics at Ta = 0 to +70°C, V_{CC} = 5.0 V ±10%

| Parameter | Symbol | Conditions | | Unit | | |
|----------------------|------------------|------------|-----|------|-----|----|
| | Symbol | Conditions | min | typ | max | |
| Cycle time | t _{CYC} | | 100 | | | ns |
| Address access time | t _{AA} | | | | 100 | ns |
| CE access time | t _{CA} | | | | 100 | ns |
| OE access time | t _{OA} | | | | 40 | ns |
| Output hold time | t _{OH} | | 20 | | | ns |
| Output disable time* | t _{OD} | | | | 30 | ns |

Note: * t_{OD} is measured from the earlier edge of the \overline{CE} (CE) or $\overline{OE}(OE)$'s going high impedance. This parameter is periodically sampled and not 100% tested.

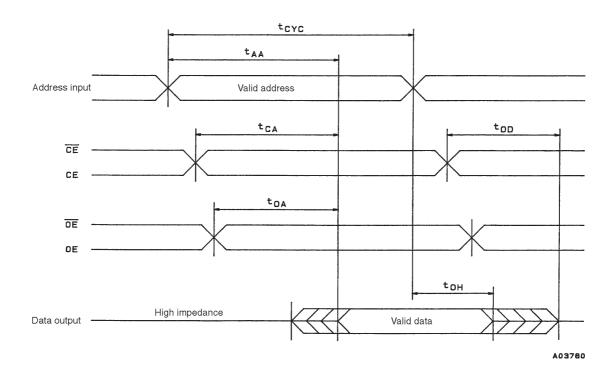
AC Test Conditions

| Input pulse levels | 0.4 V to 0.8 V _{CC} (3 V measurement), 0.4 V to 2.8 V (5 V measurement) |
|----------------------|---|
| Input rise/fall time | 5 ns |
| Input timing level | 1.5 V |
| Output timing level | 1.5 V |
| Output load | 70 pF (3 V measurement) See figure (5 V measurement) |



Output Load (5 V measurement)

Timing Chart



System Design Notes

These LSIs adopt an internal synchronization technique in which operation is started by detecting changes in either the CE input or the address inputs. As a result, the output data immediately after power on is invalid. Once power has been applied, valid data is output after the application changes the value of either the CE input or at least one of the address inputs.

Another point due to the use of the ATD technique is that these LSIs are extremely sensitive to input noise. Applications must take precautions to provide stable input signals, both for the CE input and the address inputs, to prevent incorrect operation.

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